

Device Modeling Report

COMPONENTS: THYRISTOR
PART NUMBER: 2N6405
MANUFACTURER: ON SEMICONDUCTOR



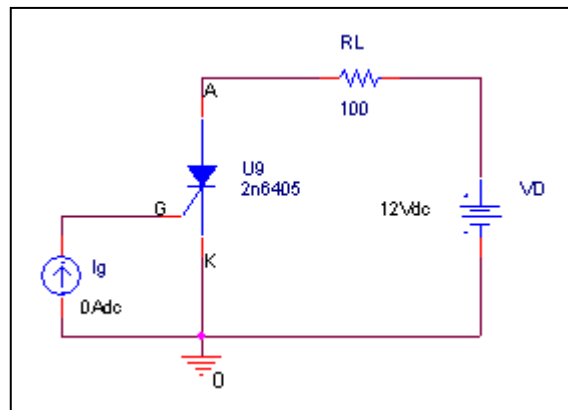
Bee Technologies Inc.

DIODE MODEL

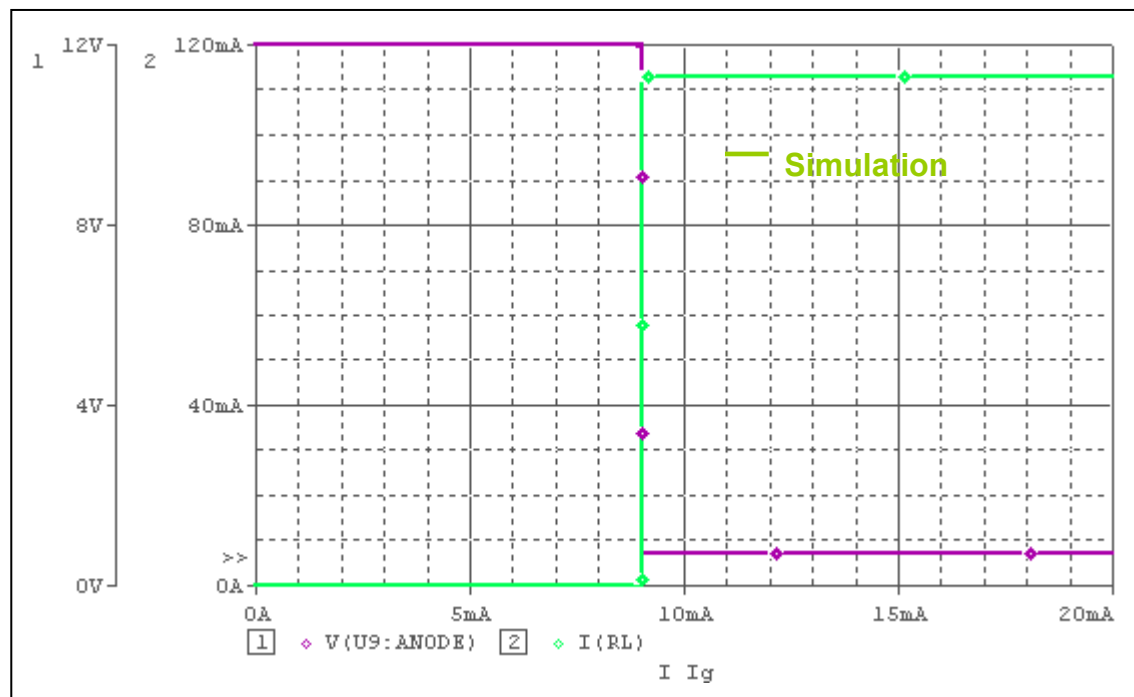
Pspice model Parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time

IG-VT Characteristic

Evaluation Circuit



Simulation result

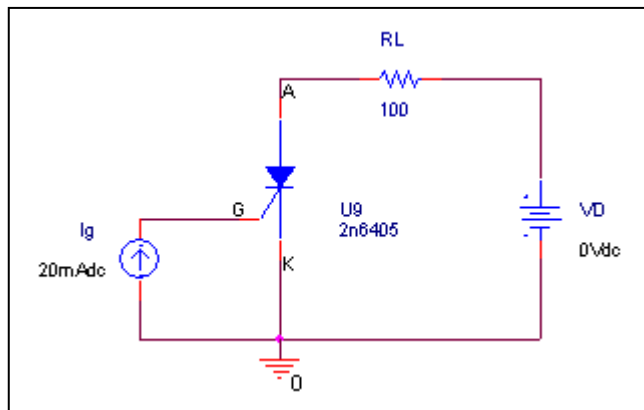


Comparison Table

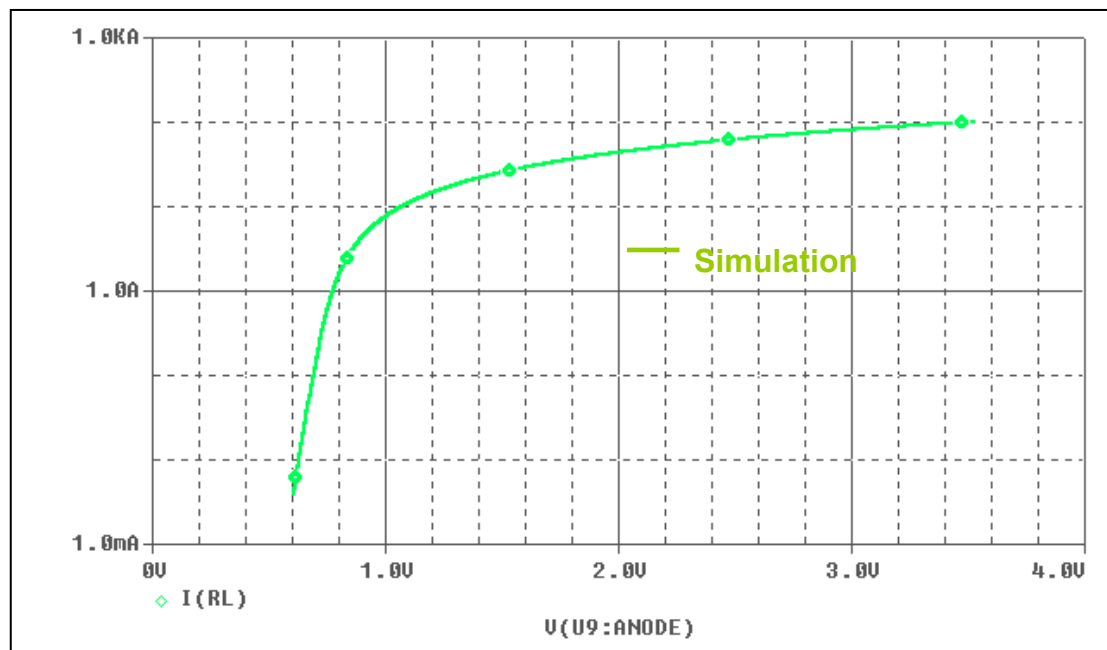
	Measurement	Simulation	% Error
I_{GT} (mA)	9	8.9762	-0.26444
V_{GT} (V)	0.7	0.695863	-0.59100

ITM-VTM Characteristic

Evaluation Circuit



Simulation result

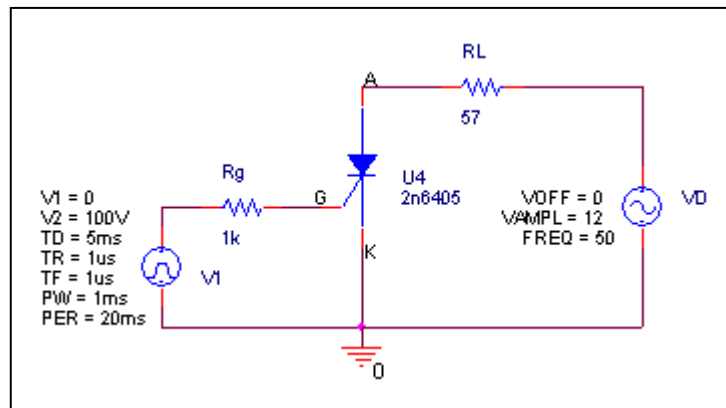


Comparison Table

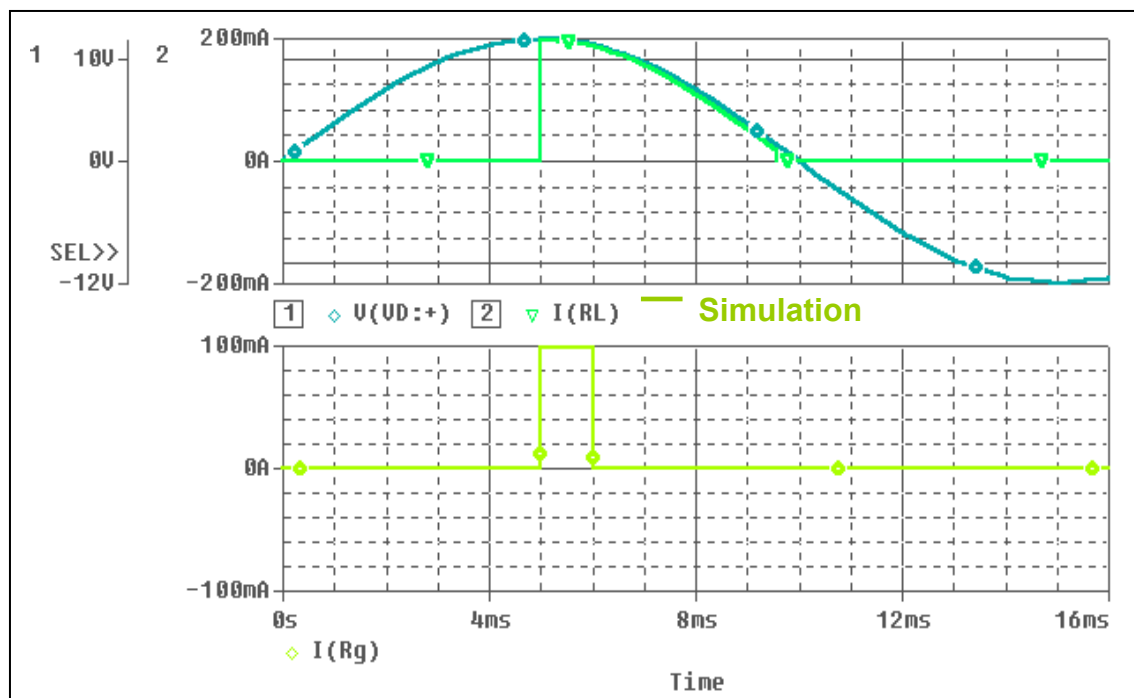
At ITM=32A	Measurement	Simulation	% Error
VTM(V)	1.7(max)	1.6893	-0.62941

Holding Characteristic (IH)

Evaluation Circuit



Simulation result

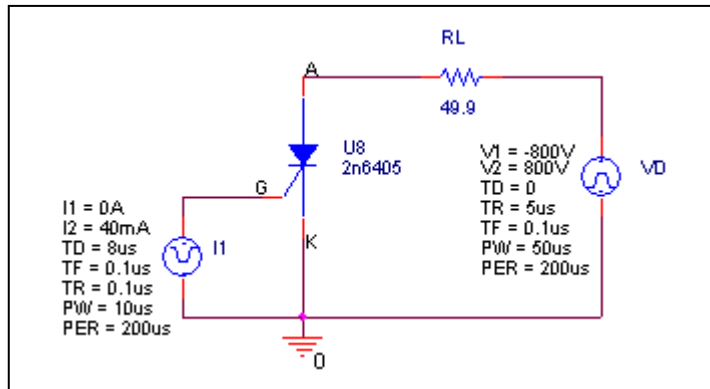


Comparison Table

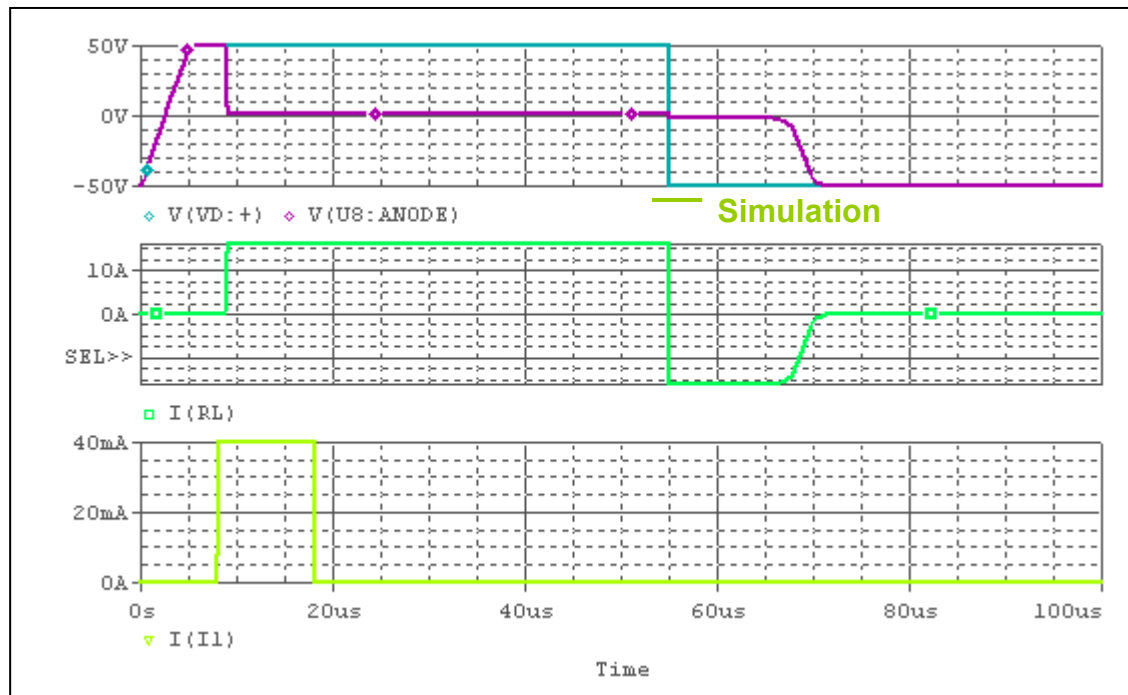
VD=12V	Measurement	Simulation	% Error
IH(mA)	18	18.205	1.13889

Switching Time Characteristic

Evaluation Circuit



Simulation result



Comparison Table

	Measurement	Simulation	%Error
Ton(us)	1	1.0255	2.55000
Toff(us)	15	14.983	-0.11333